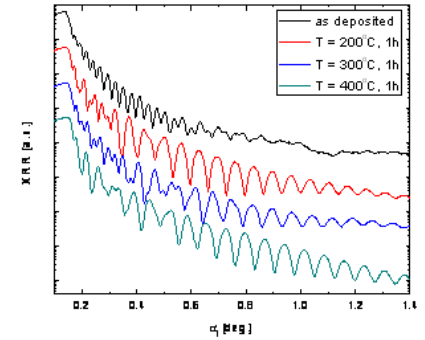
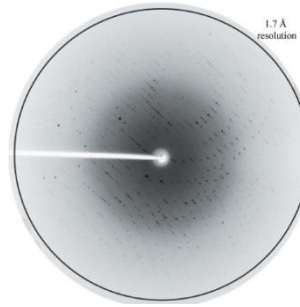
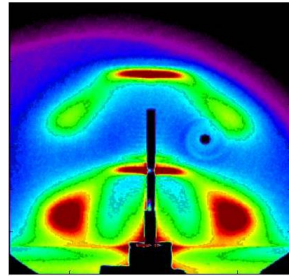
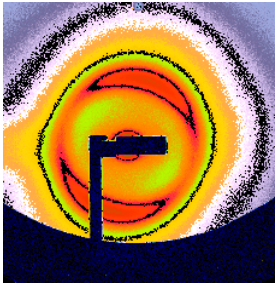


Synchrotron radiation work at RBI



Maja Buljan

Department of Material Physics

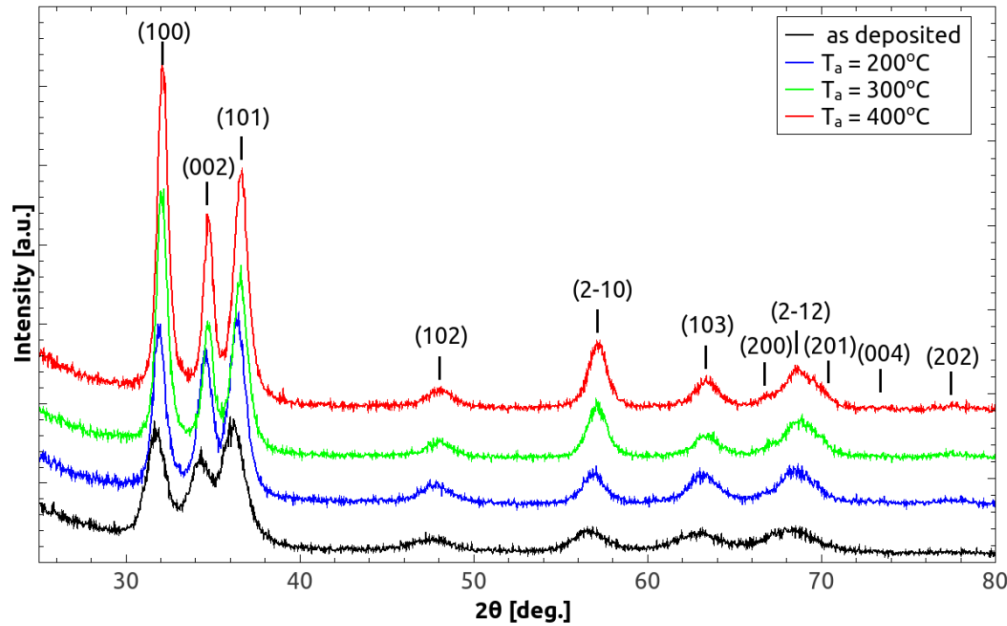
Ruđer Bošković Institute, Zagreb, Croatia

- ❖ Synchrotron users from RBI
- ❖ Structure determination by GISAXS technique
 - quantum dot lattices
 - ion beam modified surfaces
 - GisaxStudio*: software for GISAXS analysis

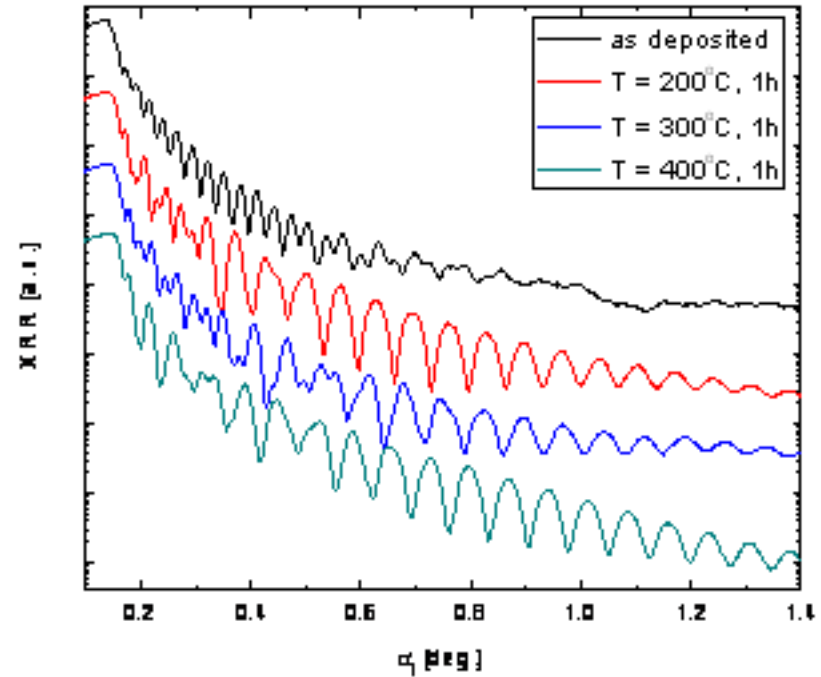
- ❖ There are about 50 active users from five research organizations in Croatia.
- ❖ They use most of the EU synchrotrons, but synchrotron *Elettra* Trieste is the most attended one.
- ❖ More than half of them is from Ruđer Bošković Institute - RBI
- ❖ About one third of them are from the Department of Material Physics, RBI
- ❖ Department of Material Physics produce about 10 publications per year based on synchrotron measurements.

- ❖ MCX beamline: GIXRD, XRR
- ❖ XRD1 beamline: XRD
- ❖ EXAFS beamline: XANES
- ❖ SAXS beamline: SAXS, GISAXS, WAXS

Crytsalline structure (ZnO)

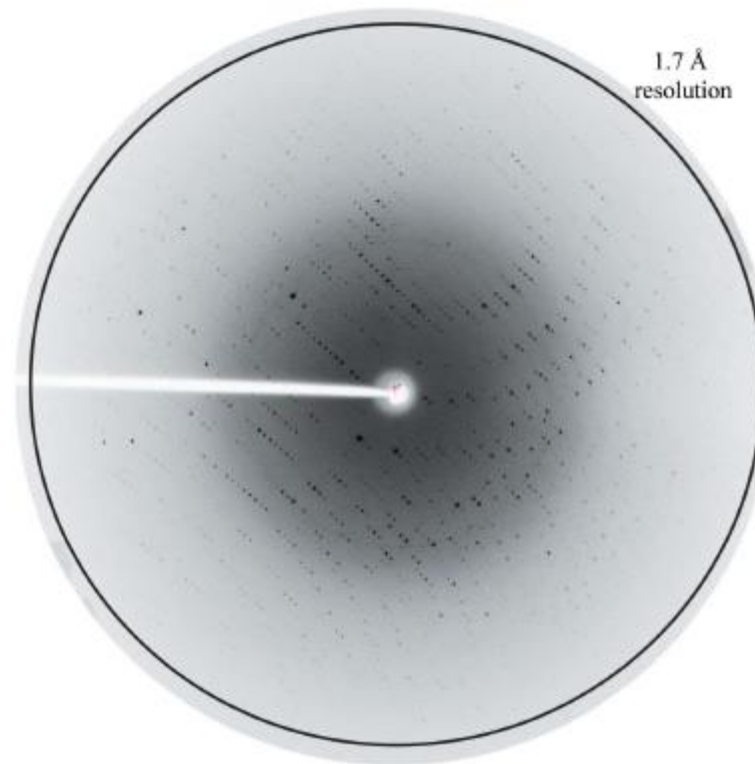


Film thickness and roughness (a-Si)



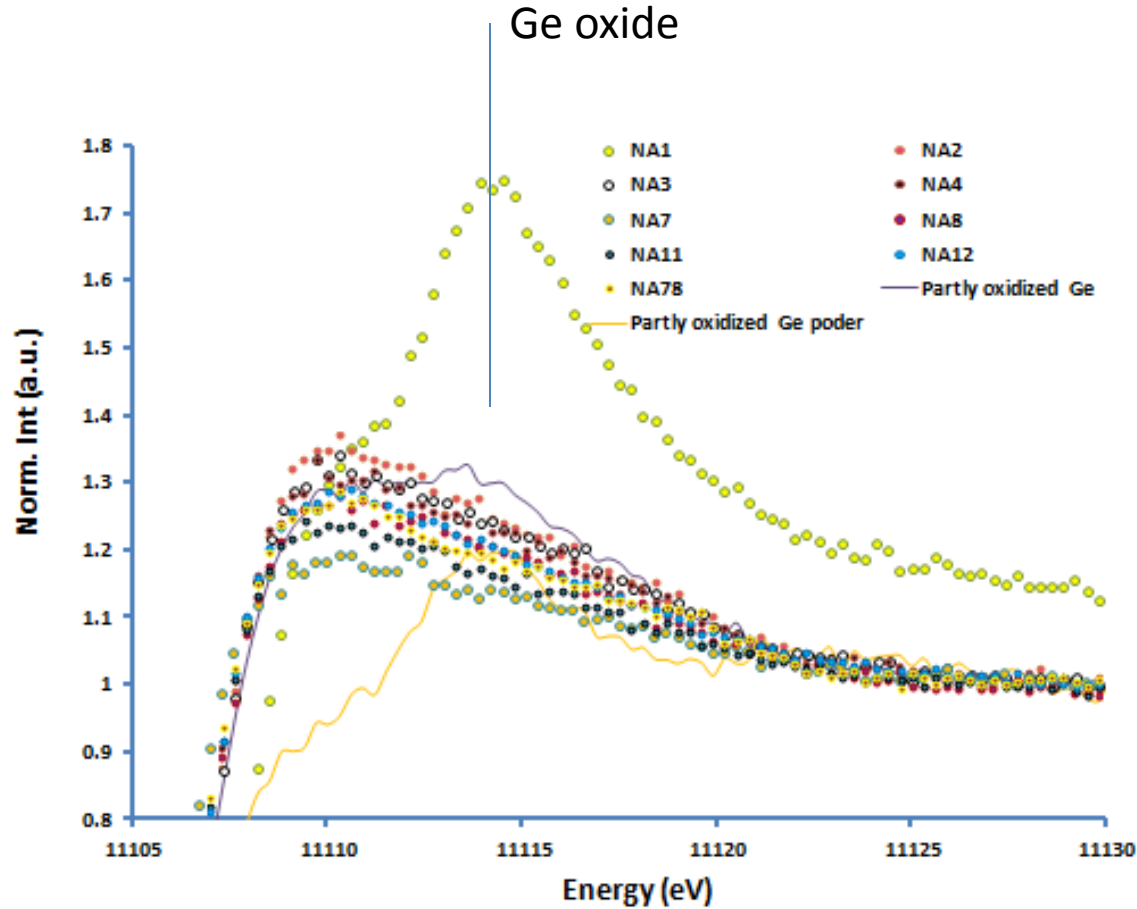
K. Juraić, et al. (unpublished)

Protein structure determination



I. Lešćić Ašler et al., Acta Cryst F 67 , 1378 (2011)

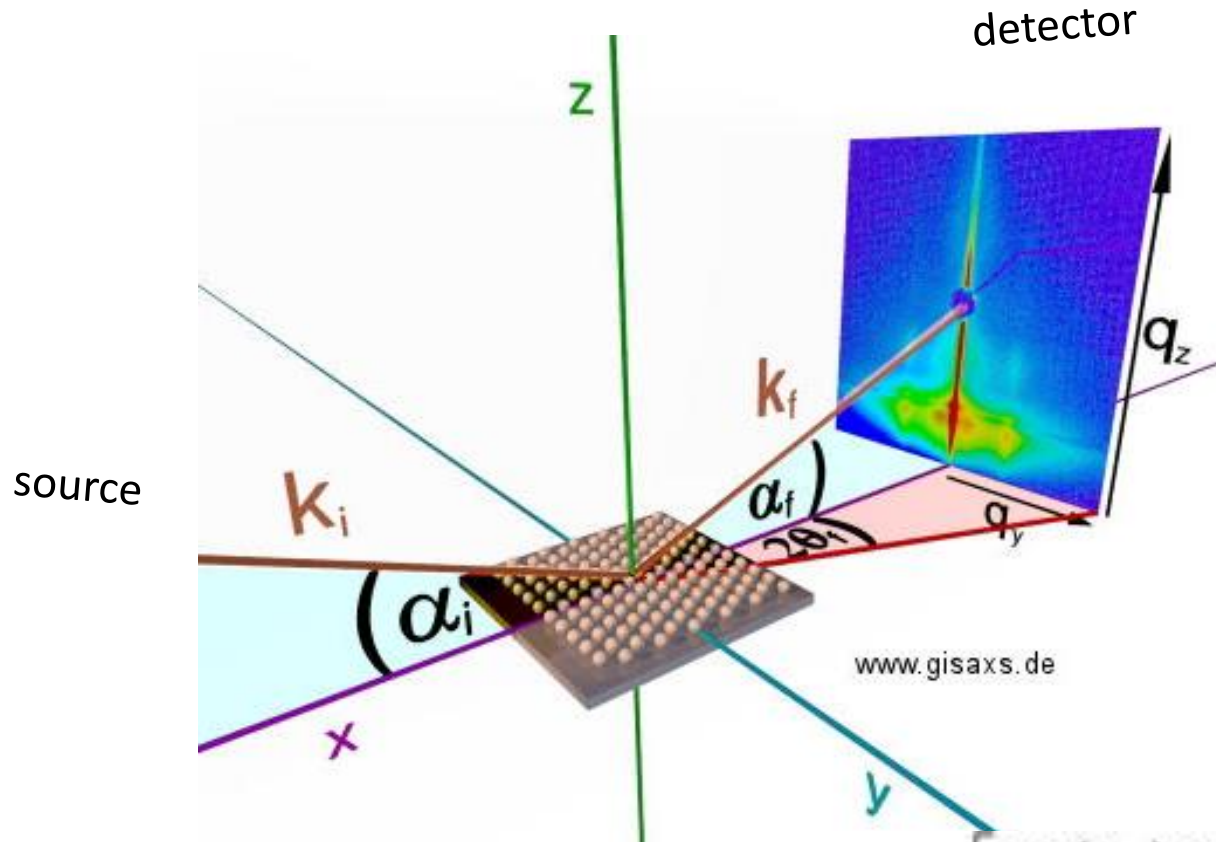
Ge/Si quantum dots



Ge K edge XANES spectra of Ge/Si/Al₂O₃ samples

M. Buljan, S. Fazinić et al, (unpublished)

Started with measurements in 1997 (Pavo Dubček, A. Turković)

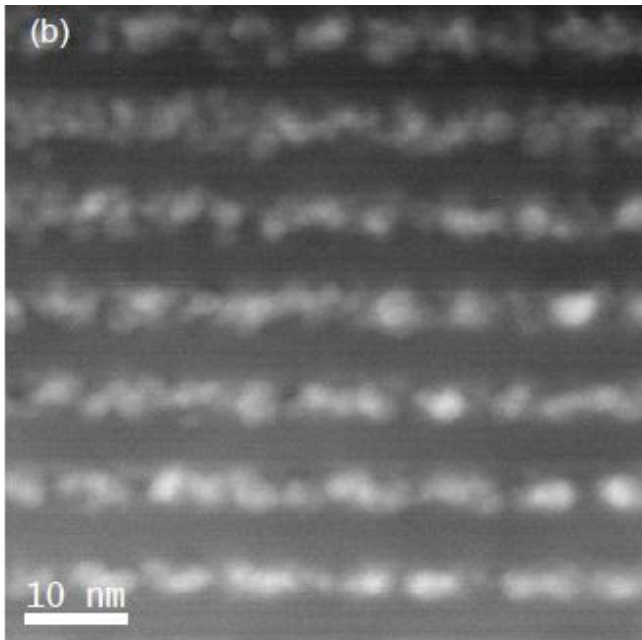


Scatteing vector: $\mathbf{q} = \mathbf{k}_f - \mathbf{k}_i$

$$q_{x,y,z} = \frac{2\pi}{\lambda} \begin{bmatrix} \cos(\alpha_f) \cos(2\theta_f) - \cos(\alpha_i) \\ \cos(\alpha_f) \sin(2\theta_f) \\ \sin(\alpha_f) + \sin(\alpha_i) \end{bmatrix}$$

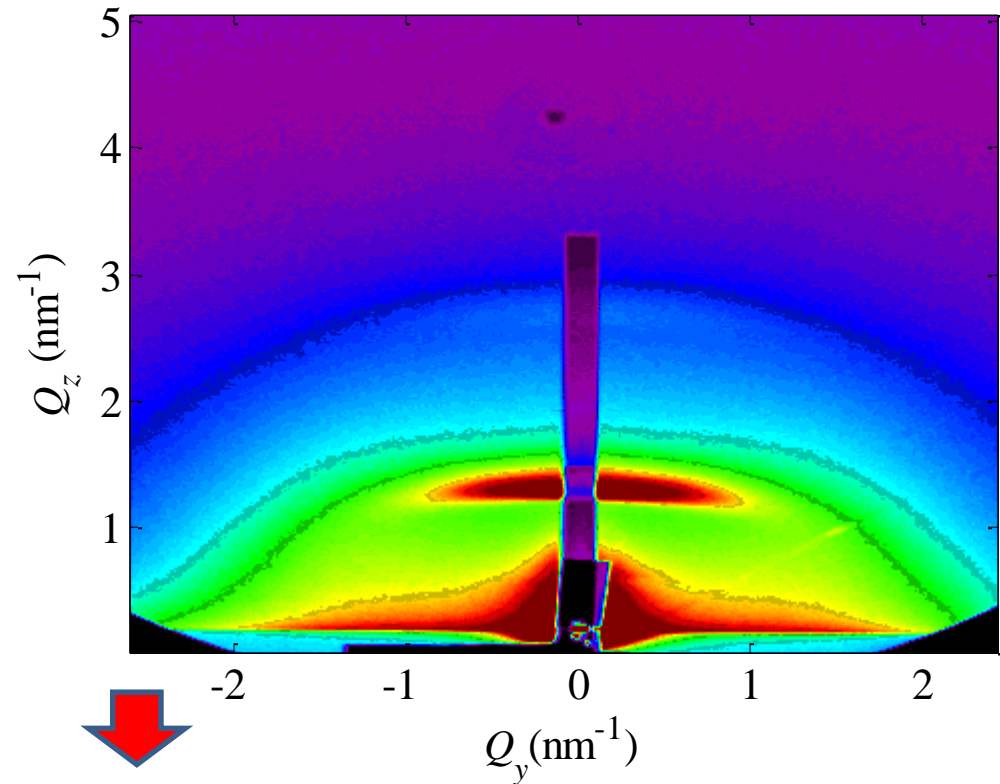
Ge QDs in SiO₂

TEM

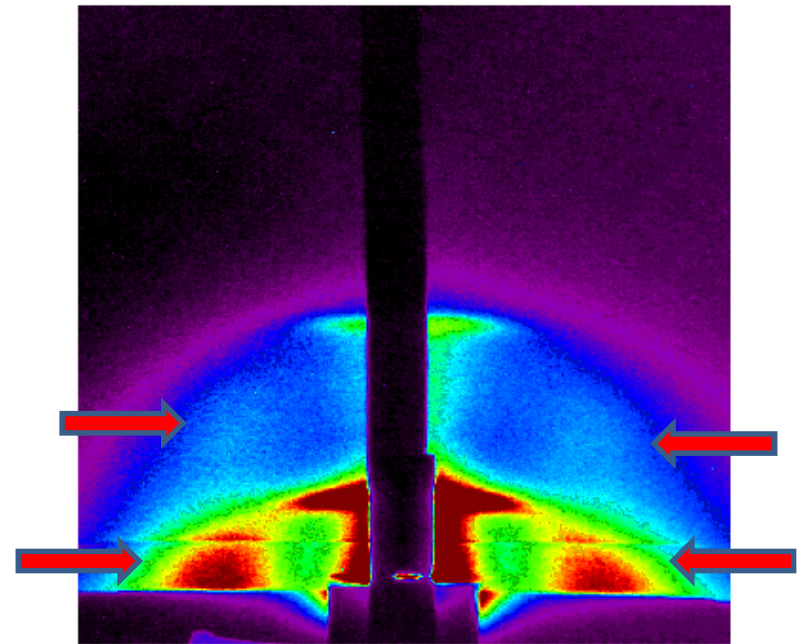
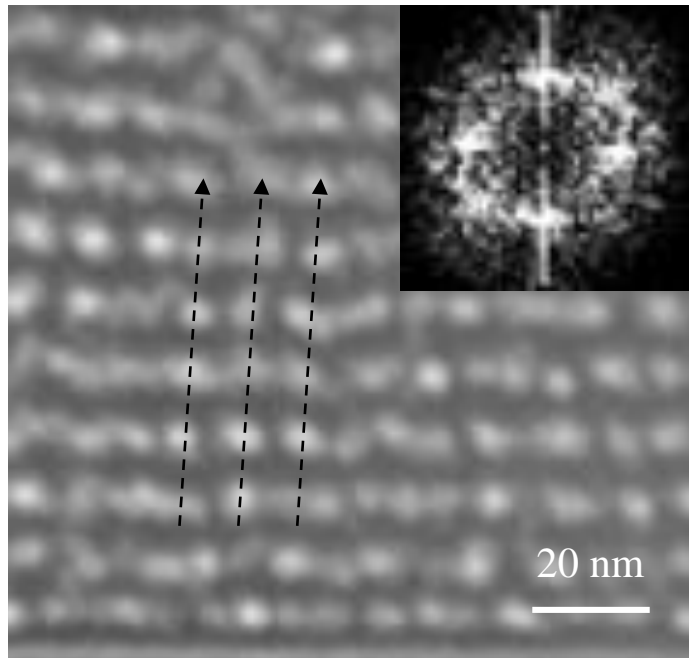


Deposition at RT

GISAXS



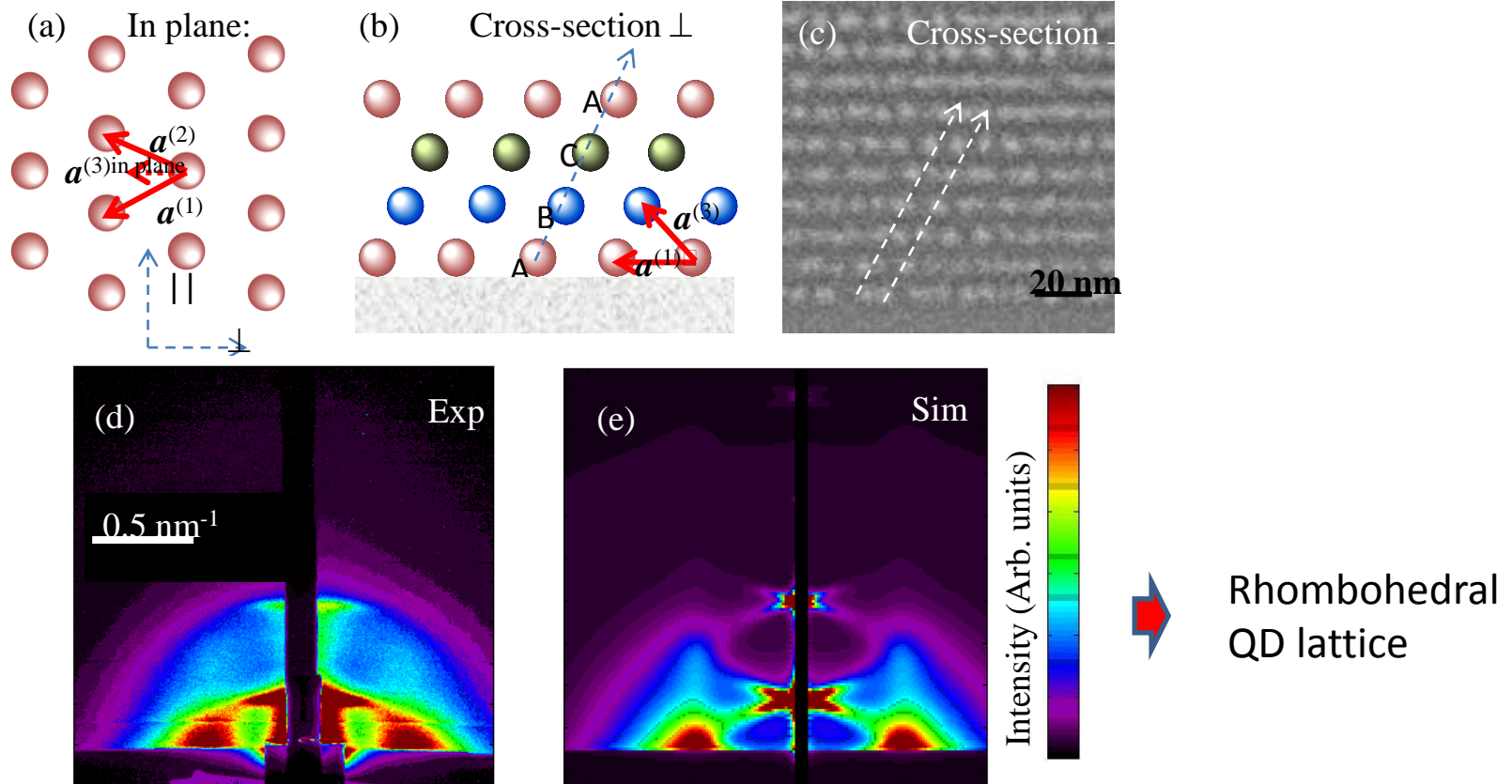
- Nanoparticles within layers

Ge QDs in SiO₂Deposition at 500°C:
ABCABC stacking

Regular 3D ordering

M. Buljan, U.V. Desnica, G. Dražić, M. Ivanda, N. Radić, P. Dubček, K. Salamon, S. Bernstorff, V. Holý; **Phys. Rev. B** 79, 035310 (2009).

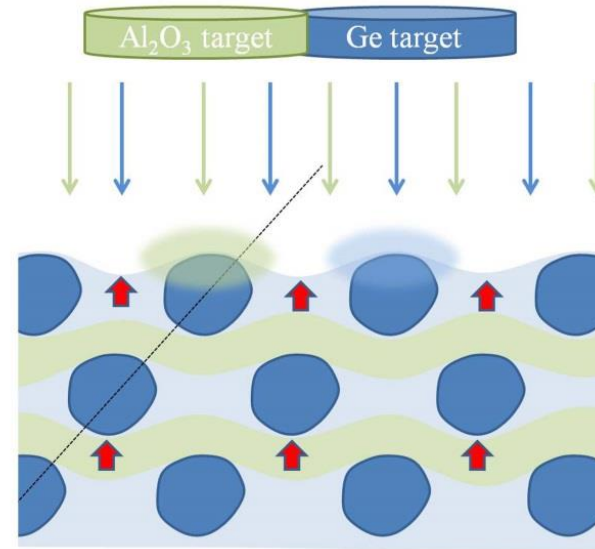
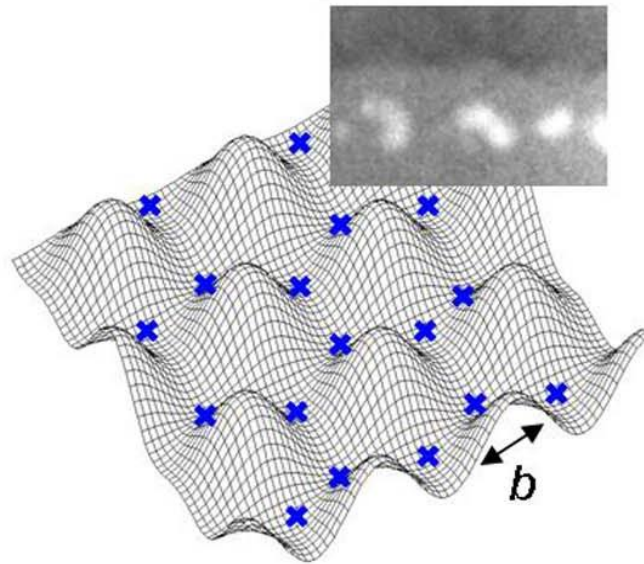
❖ 3D paracrystal model: size, shape and ordering parameters



M. Buljan, et al. *Grazing incidence small angle x-ray scattering: application in study of quantum dot lattices*, *Acta Cryst. A* 68 124 (2012)

Nucleation in walleys:

Main mechanism of self assembly

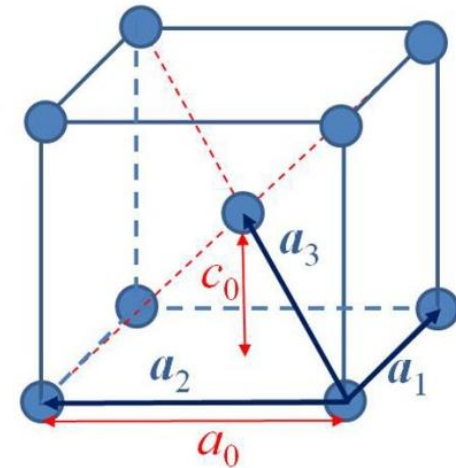
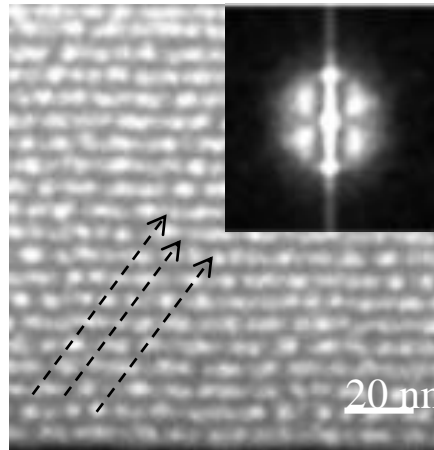
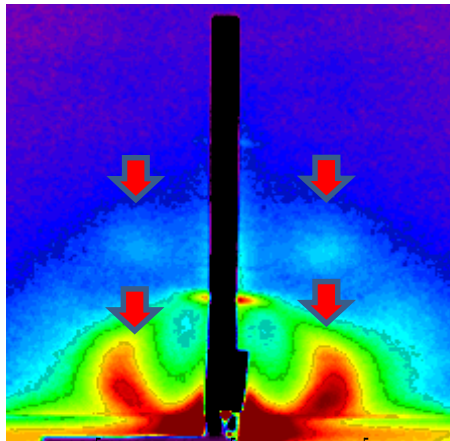


M. Buljan, U.V. Desnica, G. Dražić, M. Ivanda, N. Radić, P. Dubček, K. Salamon, S. Bernstorff, V. Holý; **Phys. Rev. B** 79, 035310 (2009).

Ge QDs in Al_2O_3

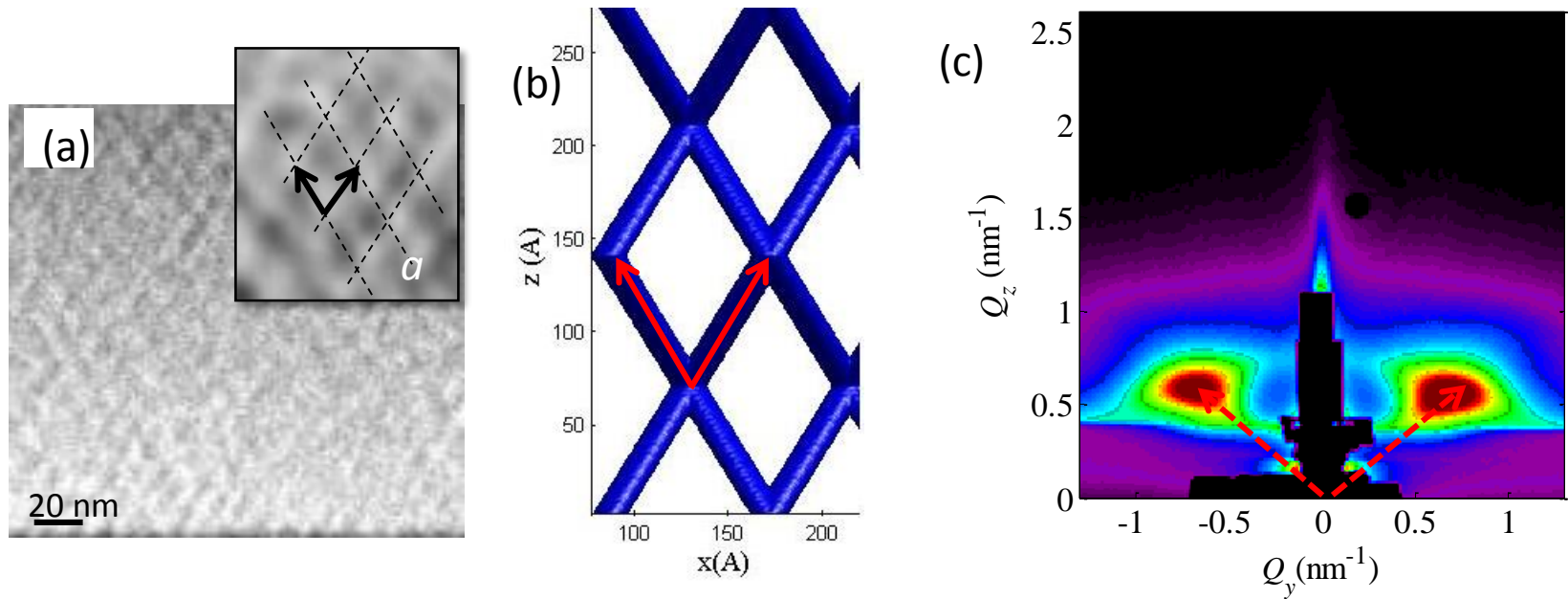
Deposition at 300°C:
ABAB stacking

BCT ORDERING!



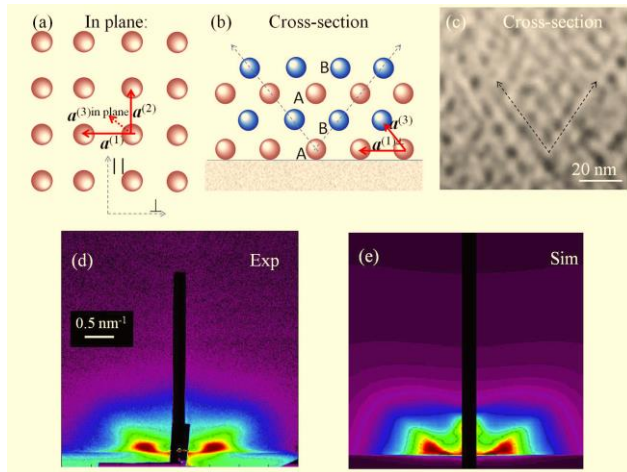
M. Buljan, N. Radić, et al. *Ge quantum dot lattices in Al_2O_3 multilayers*
J. Nanoparticle Res. 15, 1485 (2013)

Ge nanowire networks:

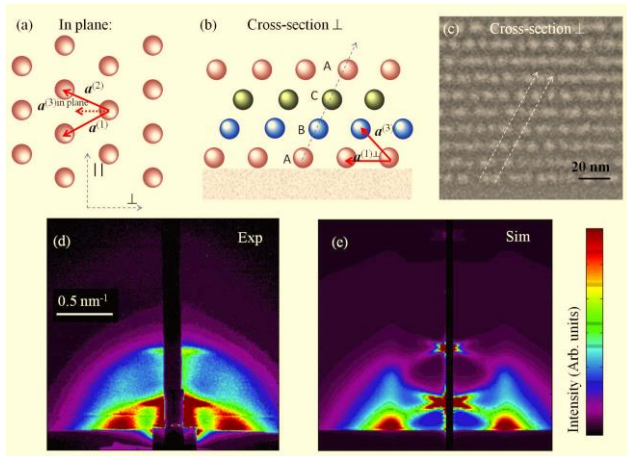


M. Buljan, et al; "Self-assembling of Ge quantum dots in an alumina matrix", *Phys. Rev. B* **82** 235407 (2010).

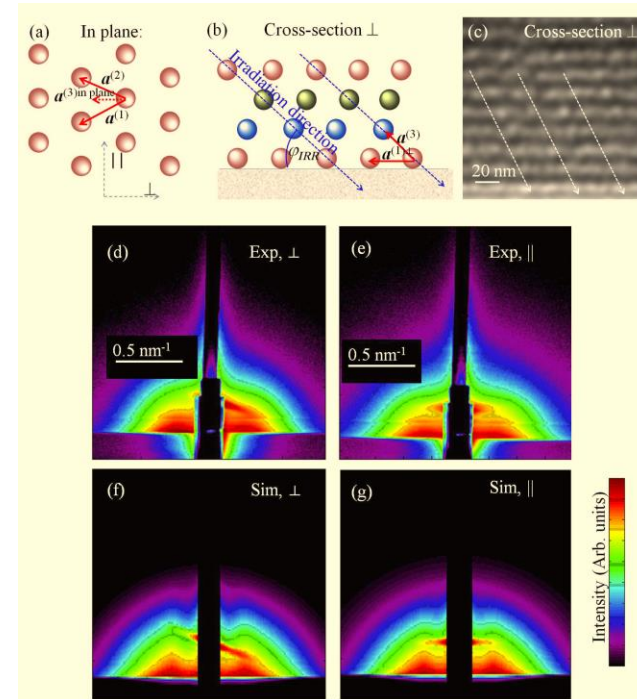
Model 1



Model 3

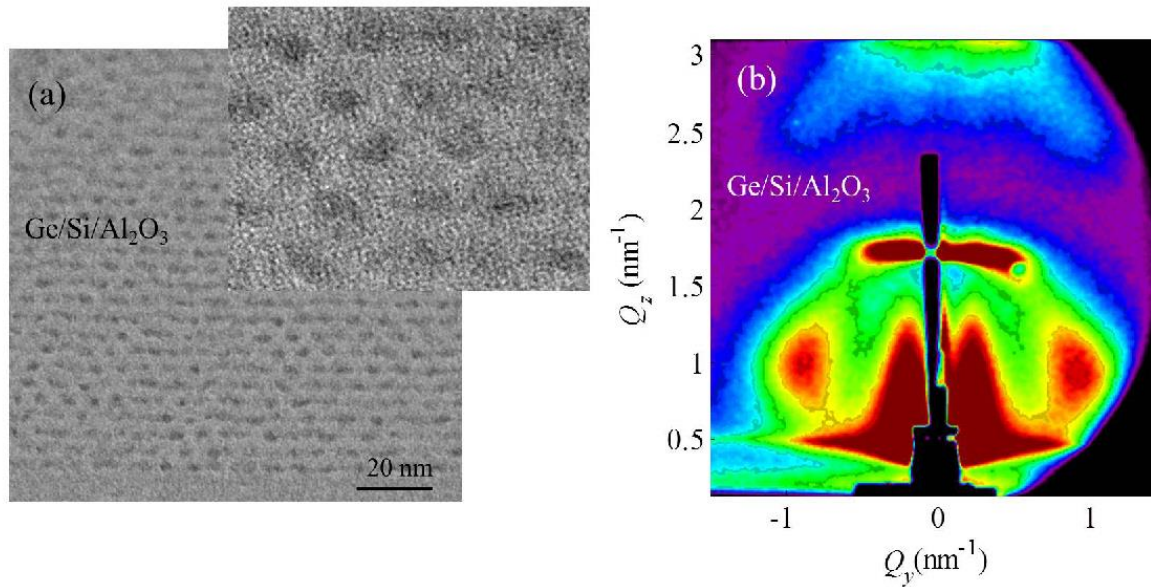


Model 2



M. Buljan, et al.

Grazing incidence small angle x-ray scattering: application in study of quantum dot lattices, Acta Cryst. A 68 124 (2012)

Ge/Si core/shell QDs in Al_2O_3 

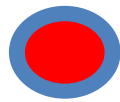
M. Buljan et al., Nanotechnology 26, 065602, (2015).

GISAXS analysis:

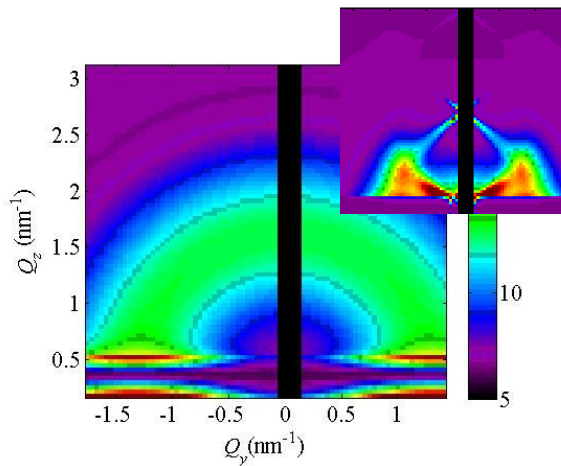
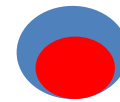
ellipsoid



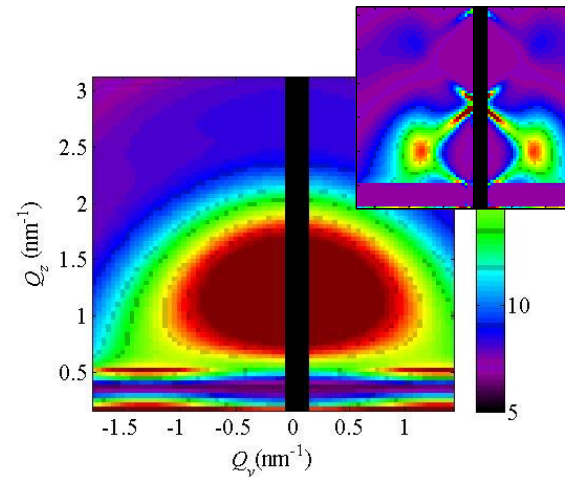
Core/shell –no shift



Core/shell – shifted origin



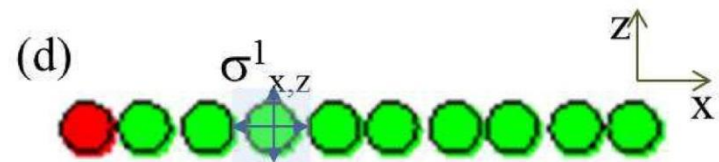
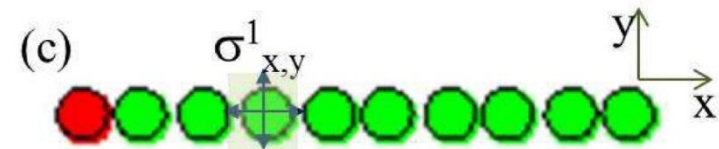
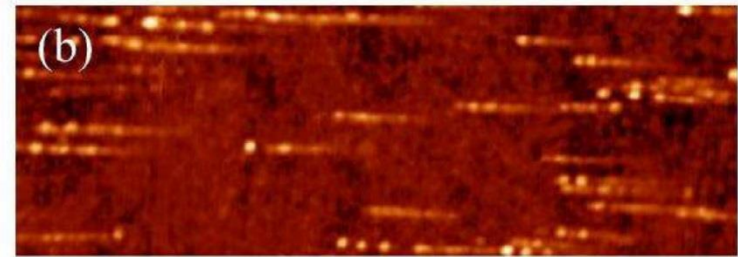
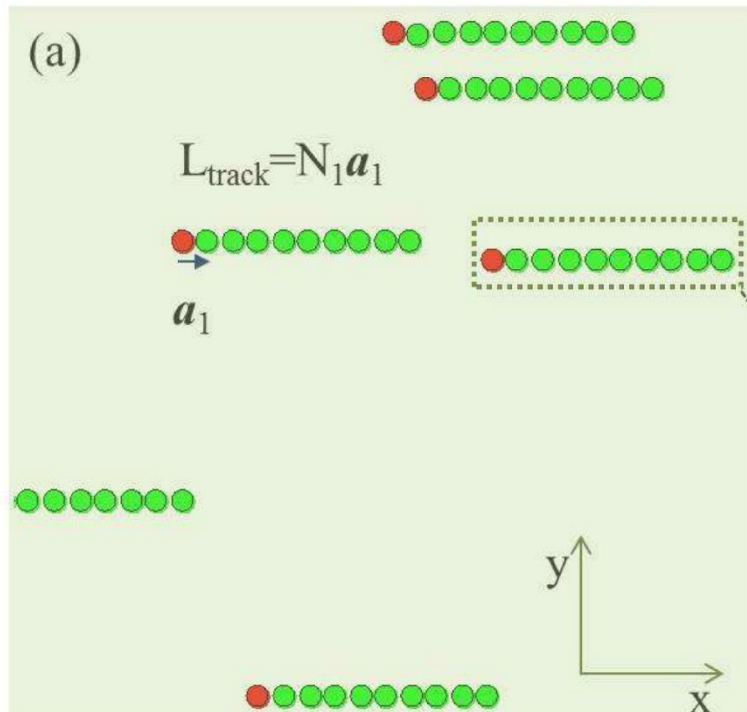
Bad fit, incorrect sizes



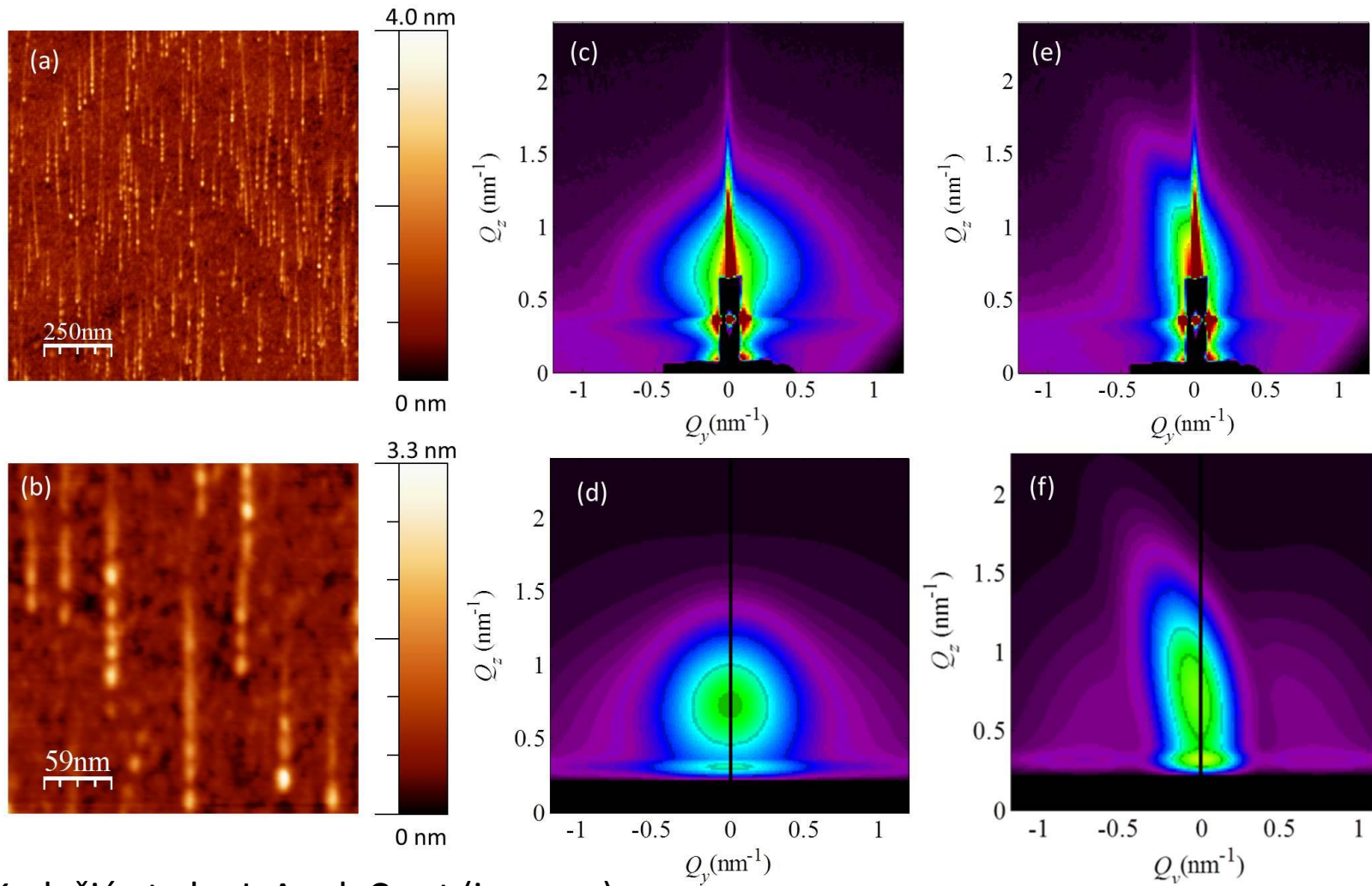
Correct values of radii

M. Buljan et al., Nanotechnology 26, 065602, (2015).

Single ion traces

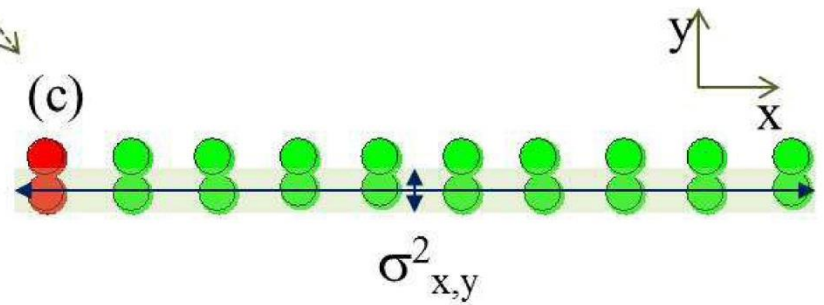
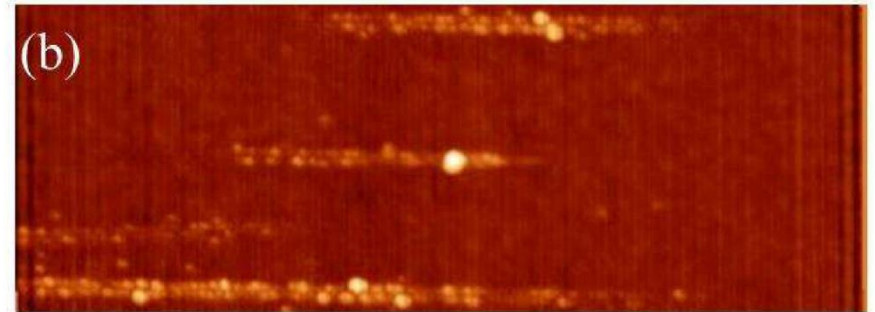
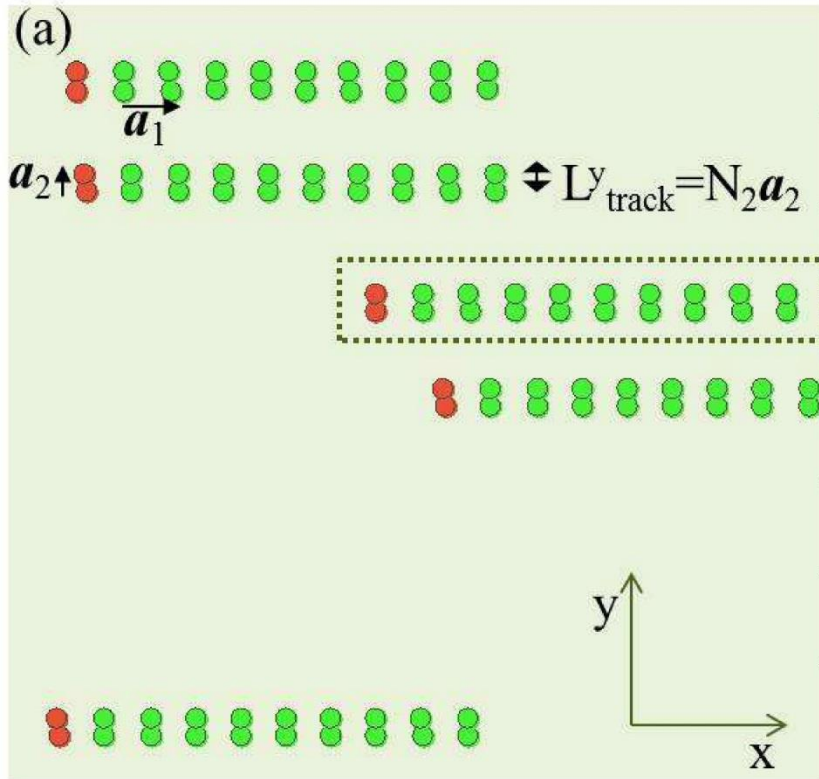


Single ion traces -example

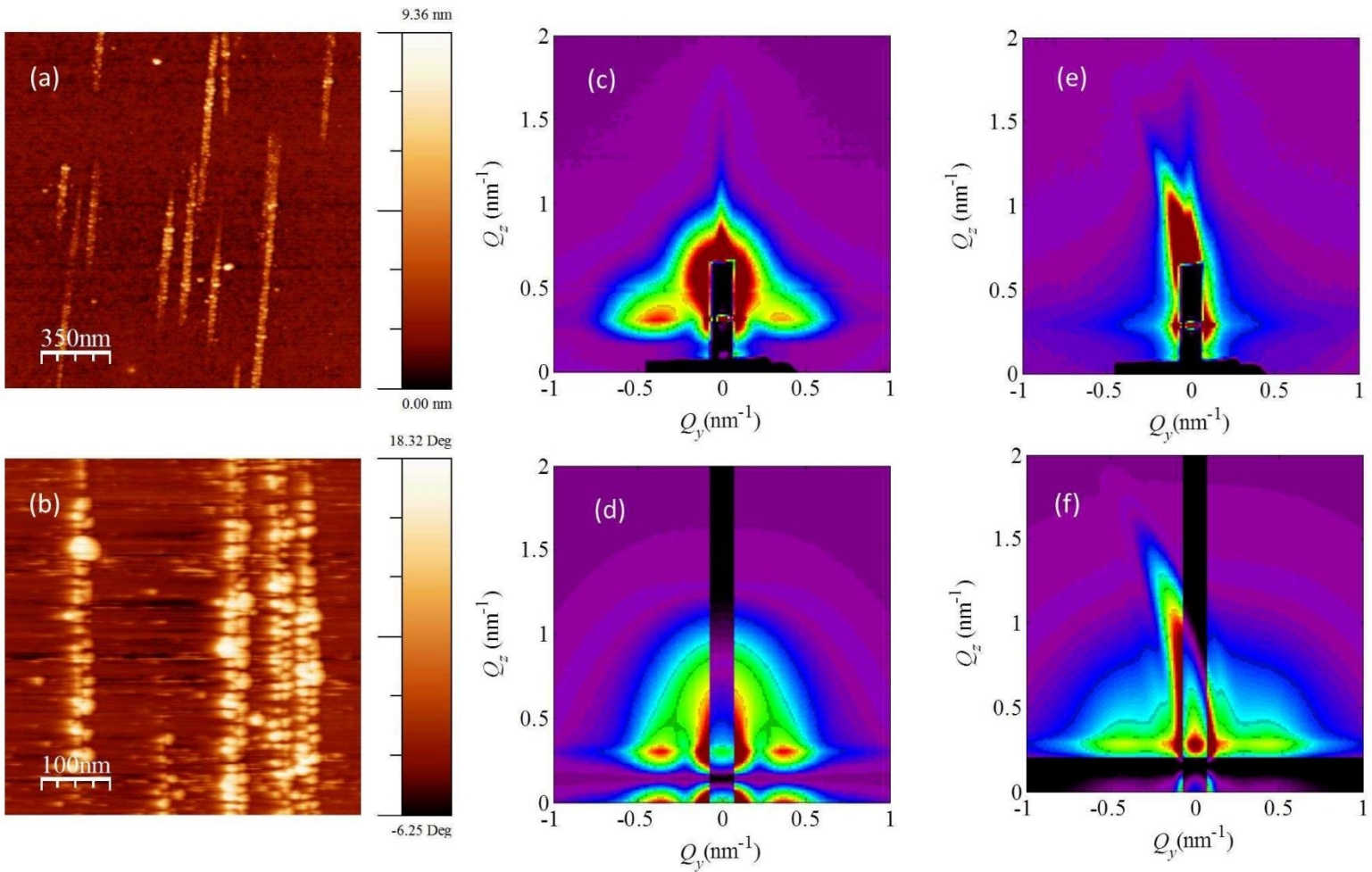


M. Karlušić et al., J. Appl. Cryst (in press)

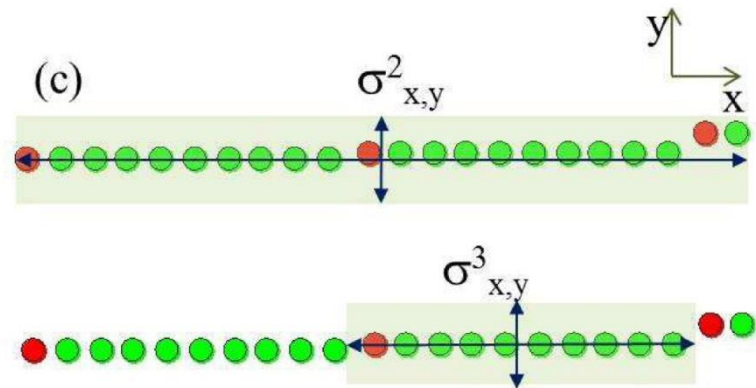
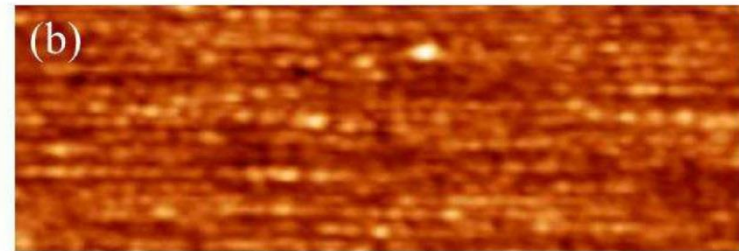
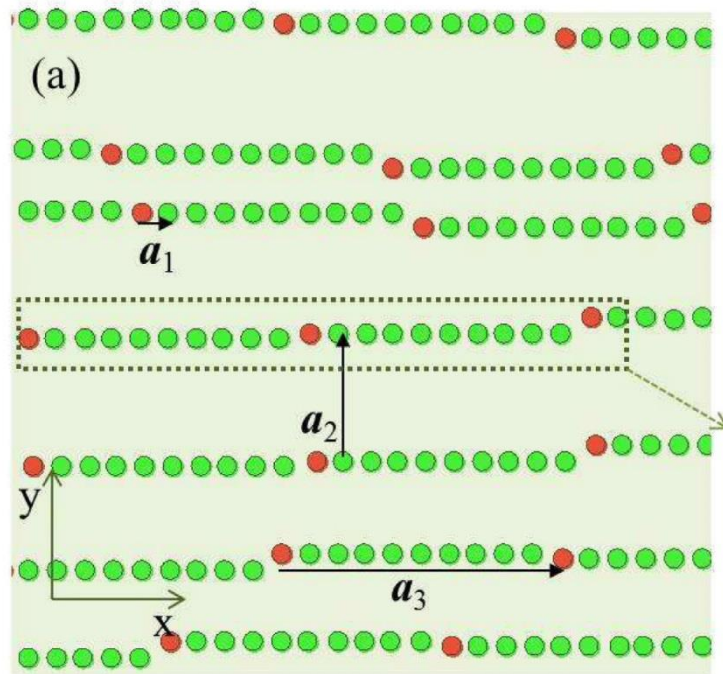
Double ion tracks



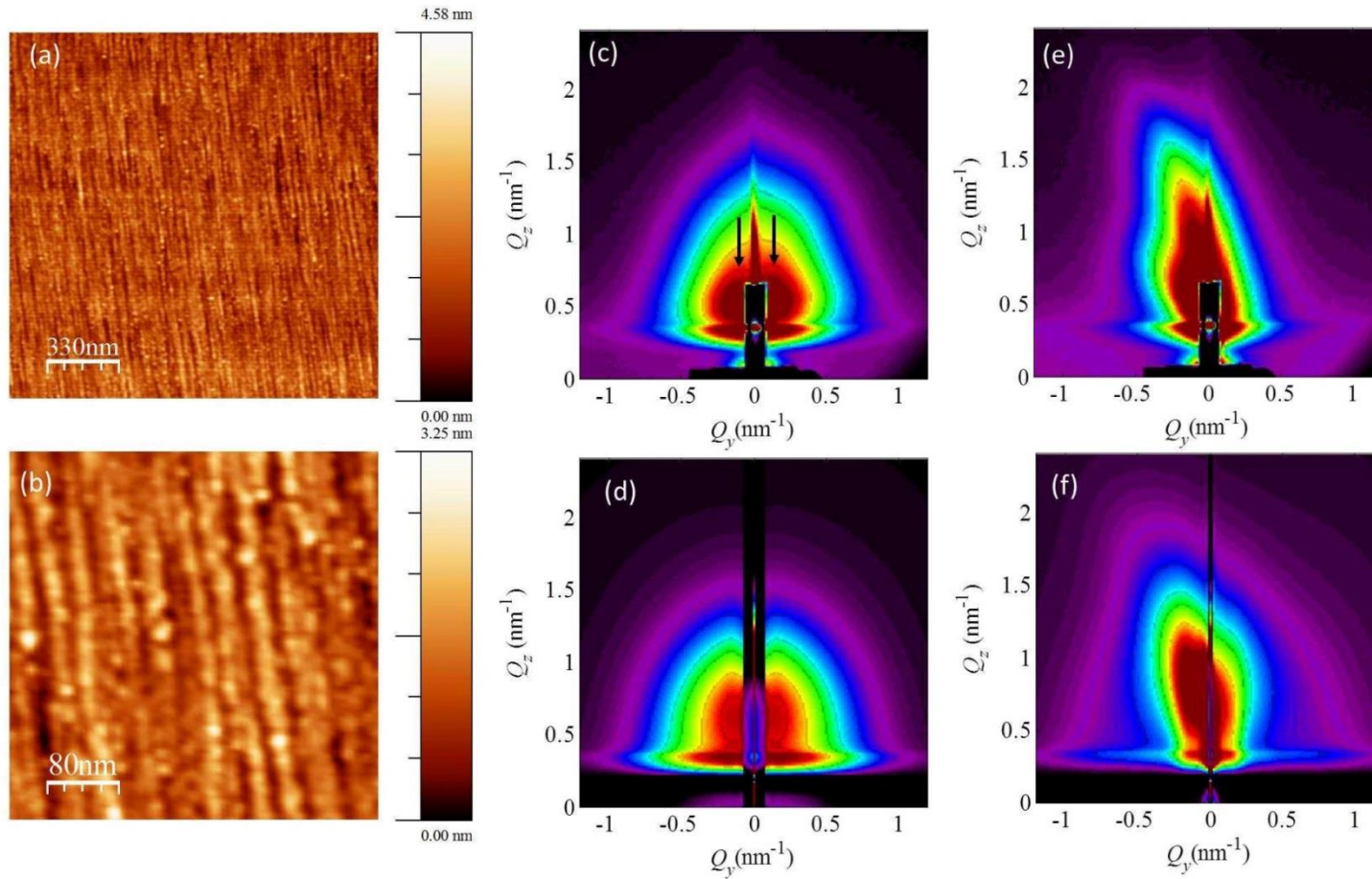
Double ion tracks - example



Correlated ion tracks



Correlated ion tracks - example





- ✓ **IMAGE PROCESSING**
- ✓ **DIFFERENT MODELS**
- ✓ **SIMULATION**
- ✓ **FITTING**
- ✓ **BATCH FIT**
- ✓ **SAVING TO DATABASE**

M. Buljan et al. Computer
Physics Communications (2016)

GisaxStudio 0.4.6. ExperimentiBeam Demo(id=8)

Experiment Reports Help

1: setup Guess:QyQz:b7ecb Guess:QyQz:bb03b Guess:QyQz:d5de0 Guess:QyQz:8e273 Fit: f=1, params:77a16 Results: f=1, params:77a16 QyQz: f=1, params:77a16

Original (f=1)

To fit rdw (y_0)

Image processing

Preprocess Smooth Replace to fit

Region of interest(s)

Set ROIs Save ROI Delete ROI

Model fitting

Model: Ion Beam One

Fit Batch fit

200 Vis. guess

Probe and y0/sp

Raster size: 1 11 21 31 41 51 61 71 81 91 See probe

y0: [slider]

Specular: [slider]

iBeam Demo

- f1 [sp=304, y0=419]
- Batch jobs

P	55.0083	60.0000	53.0000	21.0000	4.30000	4.30000	3.90832	4.12065	14.8679	4.26505	13.7465	4.46568	5.29535	25.9454	26.5749	21.9001	7.23546
UB	73.0800	72.0000	53.0000	23.1000	4.73000	4.73000	4.73000	4.73000	15.7300	4.73000	15.7300	4.73000	6.12000	27.9600	27.9600	27.9600	9.30000

<http://homer.zpr.fer.hr/gisaxstudio/>

Thank you very much for your attention!